

Notice of References Cited	Application/Control No. 10/722,606	Applicant(s)/Patent Under Reexamination LIN, CHIN-CHIH	
	Examiner Tan Le	Art Unit 3632	Page 1 of 1

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X	B	US-2004/0079858	04-2004	Rudolf, Alain	248/919
X	C	US-2004/0084578	05-2004	Cho et al.	248/125.1
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	I	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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